IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Priority Application Serial No
Priority Filing Date August 28, 2001
Inventor Leonard Forbes
Assignee Micron Technology, Inc.
Priority Group Art Unit
Priority Examiner Viet Q. Nguyen
Attorney's Docket No
Title: A Four Terminal Memory Cell, a Two-Transistor SRAM Cell, a SRAM
Array, a Computer System, a Process for Forming a SRAM Cell, a
Process for Turning a SRAM Cell OFF, a Process for Writing a SRAM Cell
and a Process for Reading Data from a SRAM Cell

INFORMATION DISCLOSURE STATEMENT

References -- See attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97, and 1.98, your attention is directed to the references which are listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

The listed references were cited by, or submitted to, the Office in the parent, co-pending application of the above-identified application. The above-identified application is a continuation application of co-pending application Serial No. 09/941,369, filed August 28, 2001. Such prior disclosure is sufficient for the above-identified application as far as copies of the references are concerned. 37 C.F.R. §1.98(d) and MPEP §609(2). However, copies of the new art cited with this filing are enclosed including references AK, AL, and AN.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated: 8 8 0 3

James D. Shaurette

Reg. No. 39,833

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	AA	5,285,687		10/1998	Yin	<u> </u>						
	AB	5,754,468		5/1998	Hobson	obson						
	AC	6,011,726		1/4/2000	Batson et	Batson et al.						
	AD	6,104,045		8/2000	Forbes et	Forbes et al						
	AE	6,128,216		10/2000	Noble, Jr.	Noble, Jr. Et al.						
	AF	6,194,759 B1		2/2001	Sano et al	Sano et al.						
	AG	6,255,165		5/2001	Noble, Jr.	Noble, Jr. et al.						
	АН	6,287,913		9/2001	Agnello et	Agnello et al.						
	AI	6,342,718 B1		1/2002	Noble							
	AJ	6,459,113 B1		10/2002	Moribara (et al.						
	AK	6,275,433 B1		8/14/2001	Forbes							
	AL	6,519,197		02/11/2003	Forbes	·						
	АМ	2002/0028550 A1		3/2002	Moribara (et al./Pub.App						
	AN	2003/0076721		4/24/03	Forbes Pu	pes Pub. App.						
		т		-	FOREIGN P.	ATENT DOCUMEN	TS			-1		
		Document Number		Date		Country		Class	Subclass	Trans	lation No	
	AO	JP2001308298A		11/2001	Hoffman	fman				165	No	
	AP	JP410335488A		12/1998	William et	a]				 		
	OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)										L	
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U.S. PATENT DOCUMENTS												
*Examiner Initial		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate				
	AA	6,184,588	2/2001	Kim et al	et al				_			
	AB	5,774,392	6/1998	Kraus et al.								
	AC	6,212,102	4/2001	Georgakos et al.								
	AD	6,265,266	7/2001	Dejenfelt et al.								
	AE	5,388,068	2/1995	Ghoshal et al.				=				
	AF	5,754,010	5/1998	Caravella et al.	-							
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